Power MOSFET 40 V, 6.9 mΩ, 44 A, Dual N–Channel Logic Level, Dual SO–8FL

Features

- Small Footprint (5x6 mm) for Compact Designs
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVMFD5852NLWF Wettable Flanks Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- This is a Pb–Free Device

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit	
Drain-to-Source Voltage			V _{DSS}	40	V	
Gate-to-Source Voltage	Gate-to-Source Voltage			±20	V	
Continuous Drain Cur-		$T_{mb} = 25^{\circ}C$	Ι _D	44	А	
rent R _{ΨJ–mb} (Notes 1, 2, 3, 4)	Steady	$T_{mb} = 100^{\circ}C$		31		
Power Dissipation	State	$T_{mb} = 25^{\circ}C$	PD	27	W	
$R_{\Psi J-mb}$ (Notes 1, 2, 3)		$T_{mb} = 100^{\circ}C$		13		
Continuous Drain Cur-		$T_A = 25^{\circ}C$	Ι _D	15	А	
rent R _{θJA} (Notes 1, 3 & 4)	Steady State	T _A = 100°C		10.6		
Power Dissipation		$T_A = 25^{\circ}C$	PD	3.2	W	
$R_{\theta JA}$ (Notes 1 & 3)		$T_A = 100^{\circ}C$		1.6		
Pulsed Drain Current	T _A = 25	°C, t _p = 10 μs	I _{DM}	329	А	
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to 175	°C	
Source Current (Body Diode)			ا _S	40	А	
Single Pulse Drain-to-Source Avalanche Energy (T _J = 25°C, V _{GS} = 10 V, I _{L(pk)} = 40 A, L = 0.1 mH, R _G = 25 Ω)			E _{AS}	80	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Mounting Board (top) - Steady State (Notes 2, 3)	$R_{\PsiJ-mb}$	5.6	°C/W
Junction-to-Ambient - Steady State (Note 3)	R_{\thetaJA}	47	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Psi (Ψ) is used as required per JESD51–12 for packages in which substantially less than 100% of the heat flows to single case surface.

3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.

4. Maximum current for pulses as long as 1 second are higher but are dependent on pulse duration and duty cycle.

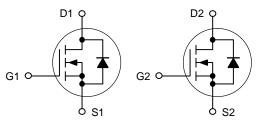


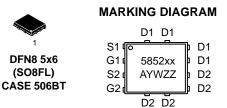
ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
40 V	6.9 mΩ @ 10 V	44 A
	12.0 mΩ @ 4.5 V	44 A







5852NL	= Specific Device Code for NVMFD5852NL
5852LW	= Specific Device Code for NVMFD5852NLWF
А	= Assembly Location
Y	= Year
Ŵ	= Work Week
ZZ	= Lot Traceability
22	

ORDERING INFORMATION

Device	Package	Shipping [†]
NVMFD5852NLT1G	DFN8 (Pb–Free)	1500 / Tape & Reel
NVMFD5852NLWFT1G	DFN8 (Pb–Free)	1500 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

© Semiconductor Components Industries, LLC, 2014 September, 2014 – Rev. 6

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

Parameter	Symbol	Test Condi	tion	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D =	250 μΑ	40	1	İ	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				37.3		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 40 V	T _J = 25°C T _J = 125°C			1.0 100	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	ő			±100	nA
ON CHARACTERISTICS (Note 5)		20 00					1
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D =	= 250 μA	1.4		2.4	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				6.3		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D	= 20 A		5.3	6.9	mΩ
		V _{GS} = 4.5 V, I _D	= 20 A		8.7	12	1
Forward Transconductance	9 FS	V _{DS} = 5 V, I _D	= 5 A		24		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 25 V			1800		pF
Output Capacitance	C _{oss}				240		1
Reverse Transfer Capacitance	C _{rss}				180		
Total Gate Charge	Q _{G(TOT)}				20		nC
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 32 \text{ V},$ $I_{D} = 20 \text{ A}$			1.5		
Gate-to-Source Charge	Q _{GS}				5.5		
Gate-to-Drain Charge	Q _{GD}				10.9		1
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 10 V, V_{DS} = 32V, I_{D} = 20 A			36		nC
SWITCHING CHARACTERISTICS (N	ote 6)						
Turn-On Delay Time	t _{d(on)}				12		ns
Rise Time	t _r	V _{GS} = 4.5 V, V _{DS}	₃ = 32 V,		52		
Turn-Off Delay Time	t _{d(off)}	V _{GS} = 4.5 V, V _{DS} I _D = 20 A, R _G :	= 2.5 Ω		21		
Fall Time	t _f				13		
Turn-On Delay Time	t _{d(on)}				12		ns
Rise Time	t _r	V _{GS} = 10 V, V _{DS}	s = 32 V,		8.0		
Turn-Off Delay Time	t _{d(off)}	$I_{\rm D} = 20$ A, $R_{\rm G} = 2.5 \ \Omega$			27		
Fall Time	t _f				5.0		
DRAIN-SOURCE DIODE CHARACTE	ERISTICS						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$		0.84	1.1	V
		$I_{\rm S} = 20 {\rm A}$	T _J = 125°C		0.69		1
Reverse Recovery Time	t _{RR}		·		22.3		ns
Charge Time	t _a	$\label{eq:VGS} \begin{array}{l} V_{GS} = 0 \ V, \ d_{IS}/d_{t} = 100 \ A/\mu s, \\ I_{S} = 20 \ A \end{array}$			12.8		1
Discharge Time	t _b				9.4		1

Reverse Recovery Charge

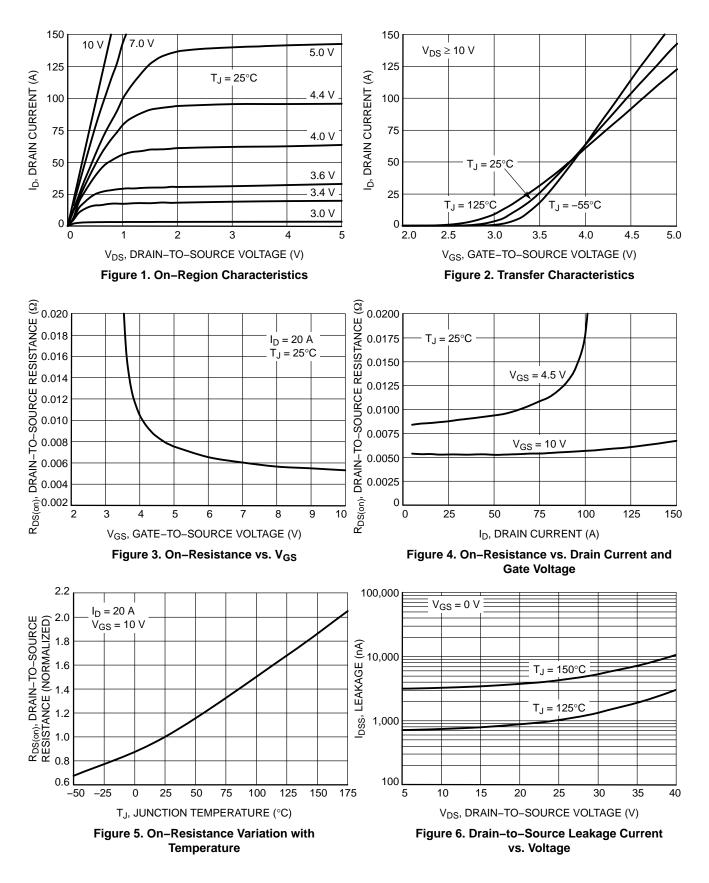
5. Pulse Test: pulse width = 300 μ s, duty cycle $\leq 2\%$. 6. Switching characteristics are independent of operating junction temperatures.

 $\mathsf{Q}_{\mathsf{R}\mathsf{R}}$

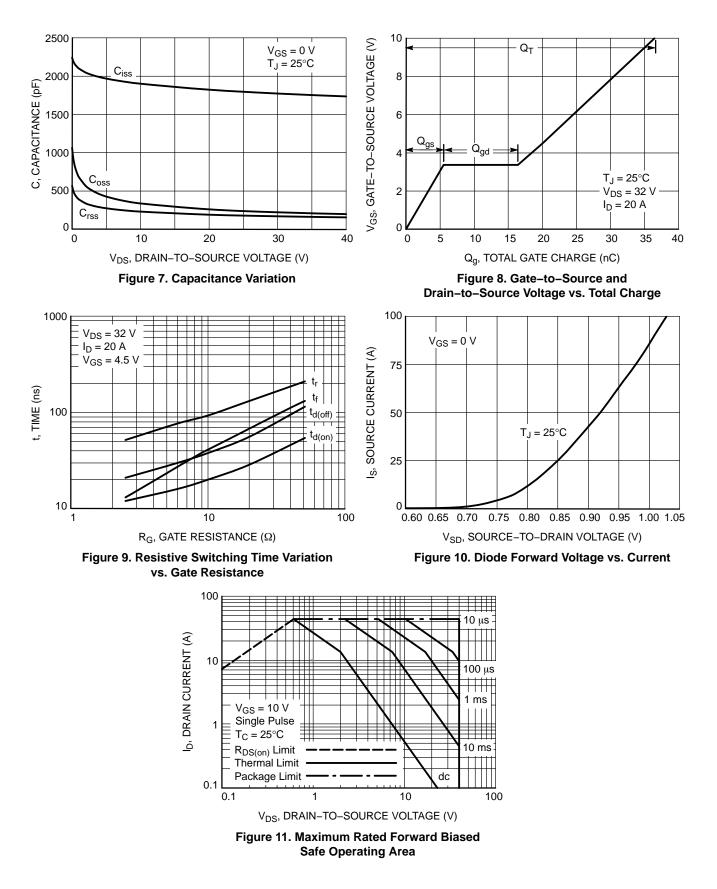
15.2

nC

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

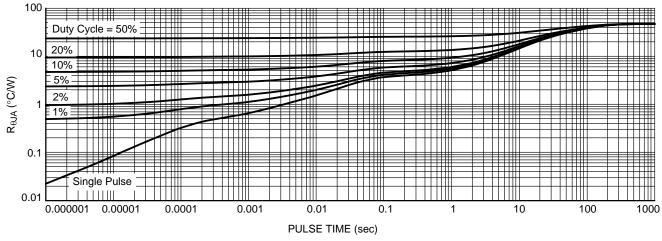
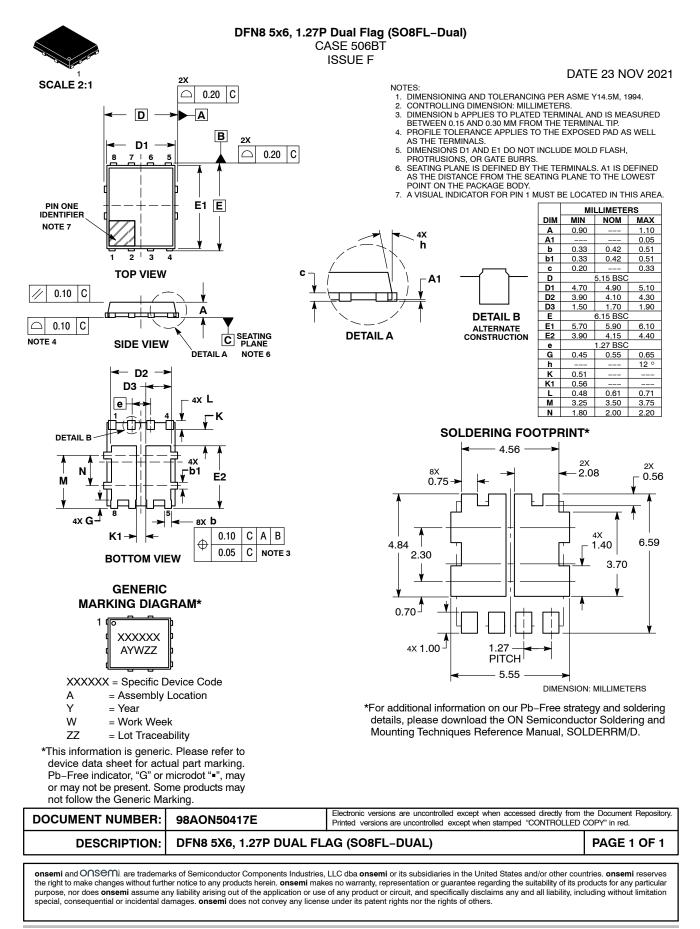


Figure 12. Thermal Response

MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS

ONSEMI



onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does **onsemi** assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using **onsemi** products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by **onsemi**. "Typical" parameters which may be provided in **onsemi** data sheets and/or specifications can and do vary in different applications and calcular performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. **onsemi** does not convey any license under any of its intellectual property rights nor the rights of others. **onsemi** products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use **onsemi** products for any such unintended or unauthorized application, Buyer shall indemnify and hold **onsemi** and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that **onsemi** was negligent regarding the design or manufacture of the part. **onsemi** is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

TECHNICAL SUPPORT

onsemi Website: www.onsemi.com

Email Requests to: orderlit@onsemi.com

North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support: Phone: 00421 33 790 2910 For additional information, please contact your local Sales Representative

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for MOSFET category:

Click to view products by ON Semiconductor manufacturer:

Other Similar products are found below :

614233C 648584F IRFD120 JANTX2N5237 FCA20N60_F109 FDZ595PZ 2SK2545(Q,T) 405094E 423220D TPCC8103,L1Q(CM MIC4420CM-TR VN1206L SBVS138LT1G 614234A 715780A NTNS3166NZT5G SSM6J414TU,LF(T 751625C BUK954R8-60E NTE6400 SQJ402EP-T1-GE3 2SK2614(TE16L1,Q) 2N7002KW-FAI DMN1017UCP3-7 EFC2J004NUZTDG ECH8691-TL-W FCAB21350L1 P85W28HP2F-7071 DMN1053UCP4-7 NTE221 NTE222 NTE2384 NTE2903 NTE2941 NTE2945 NTE2946 NTE2960 NTE2967 NTE2969 NTE2976 NTE455 NTE6400A NTE2910 NTE2916 NTE2956 NTE2911 DMN2080UCB4-7 TK10A80W,S4X(S SSM6P69NU,LF DMP22D4UF0-7B